

The peak of the graph is the point at which maximum power is generated (the so-called maximum power point). The power is negative because the SMU is absorbing the power produced by the cell.

If we used the technique from Figure 2, we could also measure the solar cell when a negative voltage is applied (reverse bias). This gives us some useful information. Firstly, it tells us that the device doesn't break down under reverse bias. This is a sign that the device is of good quality. Secondly, it tells us whether there is any extra current available. By applying a negative voltage, we can effectively suck charges out of the device that wouldn't otherwise be extracted. While these sucked charges can't be used to generate power (we're actually putting power into the device at this point, rather than extracting it), it allows us to understand some of the photo current loss mechanisms. Thus, measuring IV curves is one of the most important tools used in solar cell development and optimization. Similarly, taking IV curves is extremely important to understanding a wide range of other device types, including LEDs and OLEDs, transistors, sensors, and many more other devices.



Figure 7. Source measurement unit ADALM1000 from Analog Devices.

Starting with this article, we will begin a monthly series around the SMU ADALM100 and show some interesting experiments with it. In case you want to follow the experiments and are interested in the ADALM1000, you could get them from our distributors: [Digi-Key](#) and [Mouser](#).

Quiz:

Question 1:

In Figure 5, the maximum power of a solar cell is given. Which physical size has an influence?

Question 2:

What is the maximum power you could get out of the solar cell?

Question 3:

How is the function called to keep the output power at the maximum level? (Tip: see [ADP5091](#))

You can find the answers at the [StudentZone blog](#).

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